Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/577,296	YAMAMURA ET AL.
Examiner	Art Unit
MD YOUNUS MEAH	1652

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEAI (INCLUDING S	RCH NOTES SEARCH STRATEG	Y)
	DATE	EXMR
east	2/12/2008	MYM
stn	2/12/2008	MYM
inventors	2/12/2008	МҮМ
sequences	1/29/2008	STIC
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